



40V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _C = +25°C
40V	11.5mΩ @ V _{GS} = 10V	39A
40 V	14.5mΩ @ V _{GS} = 4.5V	35A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Power management functions
- DC-DC Converters
- Backlighting

Features

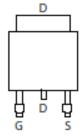
- Low On-Resistance
- Low Input Capacitance
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

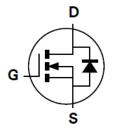
- Case: TO252-3L
- Case Material: Molded Plastic, "Green" Molding Compound.
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Weight: 0.33 grams (approximate)







Pin Out Top View



Equivalent Circuit

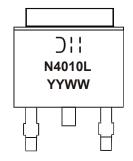
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN4010LK3-13	TO252	2500/Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



O!! =Manufacturer's Marking
N4010L = Product Type Marking Code
YYWW = Date Code Marking
YY = Last Digit of Year (ex: 13 = 2013)
WW = Week Code (01 to 53)



Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	40	V		
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Dusin Courset (Nata C) V = 40V	Steady State	T _C = +25°C T _C = +70°C	I _D	39 31	А
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	11.9 9.5	А
Maximum Body Diode Forward Current (Note 6)	Is	2	Α		
Pulsed Drain Current (10µs pulse, Duty cycle = 1%)			I _{DM}	80	Α
Avalanche Current (Notes 7) L = 0.1mH			I _{AS}	27	Α
Avalanche Energy (Notes 7) L = 0.1mH			E _{AS}	37	mJ

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)		P_{D}	1.6	W
Thermal Begintance, Junction to Ambient (Note E)	Steady state	0	78	°C/W
Thermal Resistance, Junction to Ambient (Note 5)		$R_{\theta JA}$	31	C/VV
Total Power Dissipation (Note 6)		P_{D}	2.4	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	6	51	
t<10s		$R_{\theta JA}$	21	°C/W
Thermal Resistance, Junction to Case (Note 6)		$R_{ heta JC}$	4.7	
Operating and Storage Temperature Range		$T_{J_i} T_{STG}$	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	40	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	1	_	1	μΑ	V _{DS} = 32V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance		_	8.7	11.5	mΩ	V _{GS} = 10V, I _D = 14A
Static Drain-Source On-Resistance	R _{DS (ON)}		11.1	14.5	11122	V _{GS} = 4.5V, I _D = 11A
Diode Forward Voltage	V _{SD}	_	0.72	_	V	V _{GS} = 0V, I _S = 14A
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	1810	_	pF	.,
Output Capacitance	Coss	_	135	_	pF	$V_{DS} = 20V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	112	_	pF	1 - 1.000112
Gate Resistance	Rg	_	1.7	_	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	17	_	nC	
Total Gate Charge (V _{GS} = 10V)	Qg	_	37	_	nC	V _{DS} = 20V, ,
Gate-Source Charge	Qgs	_	5.6	_	nC	I _D = 14A
Gate-Drain Charge	Q_{gd}	_	7.1	_	nC	
Turn-On Delay Time	t _{D(on)}		5.1	_	ns	
Turn-On Rise Time	t _r		13	_	ns	V _{GS} = 10V, V _{DS} = 20V,
Turn-Off Delay Time	t _{D(off)}	1	36	_	ns	$R_G = 6\Omega, I_D = 14A$
Turn-Off Fall Time	t _f		13	_	ns	1
Body Diode Reverse Recovery Time	t _{rr}		12.2	_	ns	I _S = 3A, dI/dt = 100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	_	5.4	_	nC	$I_S = 3A$, $dI/dt = 100A/\mu s$

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

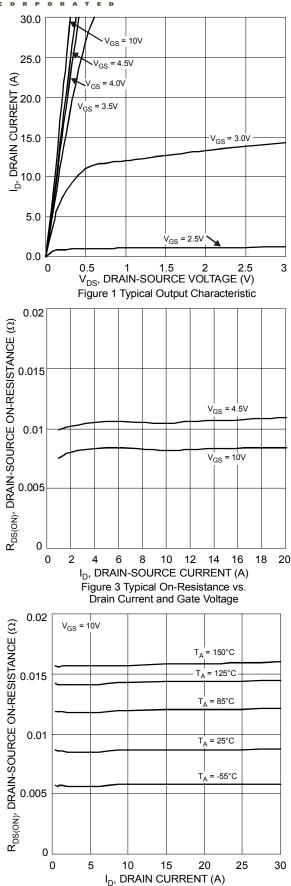
6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

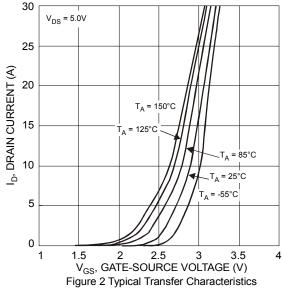
7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = 25°C

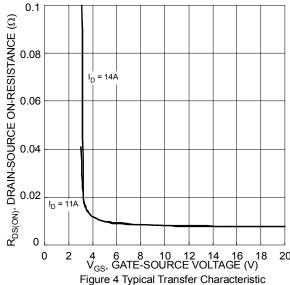
8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.









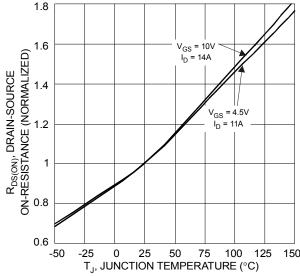
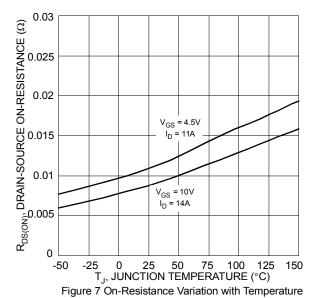
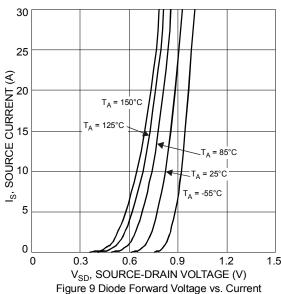


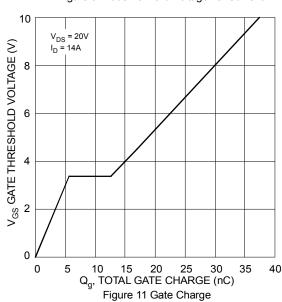
Figure 6 On-Resistance Variation with Temperature

Figure 5 Typical On-Resistance vs. Drain Current and Temperature









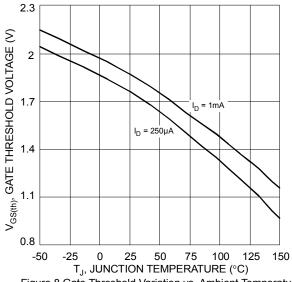
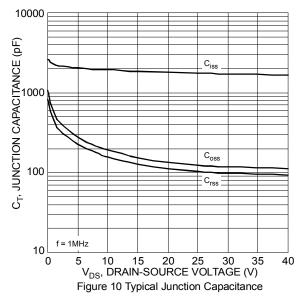
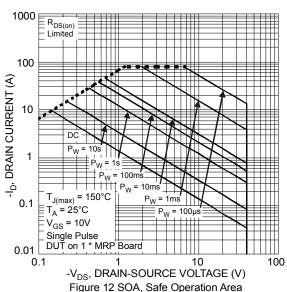
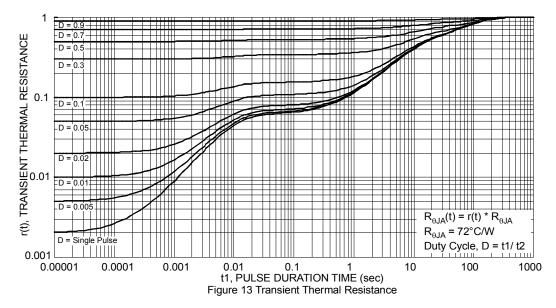


Figure 8 Gate Threshold Variation vs. Ambient Temperature



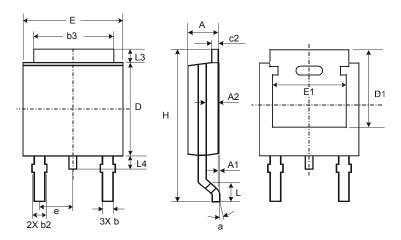






Package Outline Dimensions

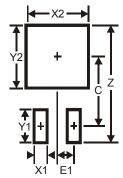
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



TO252							
Dim	Min	Max	Тур				
Α	2.19	2.39	2.29				
A1	0.00	0.13	0.08				
A2	0.97	1.17	1.07				
b	0.64	0.88	0.783				
b2	0.76	1.14	0.95				
b3	5.21	5.46	5.33				
c2	0.45	0.58	0.531				
D	6.00	6.20	6.10				
D1	5.21	_	_				
е	-	_	2.286				
Е	6.45	6.70	6.58				
E1	4.32	_	_				
Н	9.40	10.41	9.91				
L	1.40	1.78	1.59				
L3	0.88	1.27	1.08				
L4	0.64	1.02	0.83				
а	0°	10°	_				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	11.6
X1	1.5
X2	7.0
Y1	2.5
Y2	7.0
С	6.9
E1	2.3



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